# Microwave Gain Equalizer Die EQY-XX-283-D+ Series

50 $\Omega$  DC to 28 GHz

## **The Big Deal**

- Excellent Return Loss, 17dB typ.
- Wide bandwidth, DC 28 GHz
- Usable up to 30GHz

Tage MF8A

## **Product Overview**

EQY-XX-283-D+ series of absorptive Gain Equalizer dice are fabricated using highly repetitive GaAs IPD\* MMIC process incorporating resistors, capacitors and inductors having negative insertion loss slope. EQY-XX-283-D+ are available with nominal attenuation slope of 3, 4, 5 & 6 dB.

## **Key Features**

Feature	Advantages			
Negative Insertion Loss Slope vs. Frequency	Useful for compensating negative gain slope of amplifiers, receivers, transmitters to achieve flat gain versus frequency.			
Wide range of values 3,4,5 & 6dB	Enables circuit designer to change nominal insertion loss values without board rede- sign making the EQY-XX-283-D+ Series ideal for select at test application.			
Wideband operation, DC to 28 GHz	Supports a wide array of applications including wireless cellular, microwave communi- cations, satellite, defense and aerospace, medical broadband and optic applications.			
Excellent Power Handling Capability	Enables its use at the output of a variety of amplifiers			
Unpackaged Die	Enables the user to integrate the gain equalizer directly into hybrids.			

\*GaAs IPD (Gallium Arsenide Integrated Passive Device)

# Microwave Gain Equalizer Die

# EQY-4-283-D+

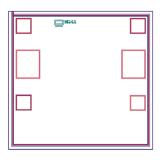
## $50\Omega$ 4dB DC to 28 GHz

#### **Product Features**

- 4.3 dB Slope from DC to 28 GHz Can work up to 30 GHz
- Good Return Loss, 17 dB typ.

#### **Typical Applications**

- Cellular Infrastructure
- 5G
- Wideband Communications
- Test Instrumentation
- Defense



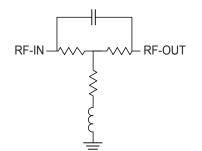
+RoHS Compliant The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

#### **General Description**

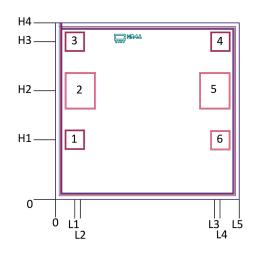
EQY-4-283-D+ is an absorptive Gain Equalizer Die fabricated using highly repetitive GaAs IPD MMIC process incorporating resistors, capacitors and inductors having negative insertion loss slope. EQY-4-283-D+ has a nominal attenuation slope of 4.3 dB.

### Simplified Schematic and Pad description



Pad Number	Description	
2	RF-Input pad	
5	RF-Output pad	
1,3,4,6 & Bottom of Die	Ground	

### **Bonding Pad Position**



	Dimensions in µm, Typical												
	L1	L2	L3	L4	L5	H1	H2	H3	H4	Thickness	Die Size	Pad Size 2 & 5	Pad Size 1,3,4,6
[	79	101	650	673	750	244	444	644	720	100	750x720	117x142	72x72

#### Electrical Specifications<sup>1</sup> at 25°C, 50Ω, unless otherwise noted.

Parameter	Condition (GHz)	Min.	Тур.	Max.	Units
Frequency Range		DC		28	GHz
Insertion Loss	0.01	_	4.9	_	dB
	10	_	4.0	_	
	20	_	1.8	_	
	28	_	0.6	_	
	30	_	0.5	_	
VSWR	0.01 - 10	—	1.14	—	:1
	10 - 20	_	1.11	_	
	20 - 28	_	1.18	_	
	28-30	_	1.21	_	

1. Electrical specifications are measured with die being packaged in 2x2 6L MCLP and mounted on Characterization Test Board TB-EQY-4-283+.

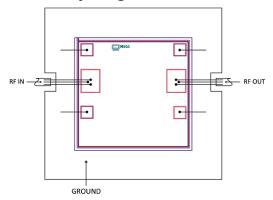
#### Absolute Maximum Ratings<sup>2</sup>

Operating Case Temperature	-55°C to 105°C
RF Input Power <sup>3</sup>	30 dBm

2. Permanent damage may occur if any of these limits are exceeded.

3. Derates linearly to 26dBm at 105°C

### **Assembly Diagram**



#### **Assembly and Handling Procedure**

1. Storage

Dice should be stored in a dry nitrogen purged desiccators or equivalent.

2. ESD

MMIC GaAs Gain equalizer dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static worksta tion. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.

3. Die Attach

The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are Ablestik 84-1LMISR4 or equivalent. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.

4. Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.



#### Additional Detailed Technical Information

additional information is available on our dash board.

	Data Table				
Performance Data	Swept Graphs				
	and without port extension(.zip file)				
Case Style	Die				
	Quantity, Package	Model No.			
Dia Ordering and packaging	Small, Gel - Pak: 5,10,50,100 KGD* Medium <sup>†</sup> , Partial wafer: KGD*<2070	EQY-4-283-DG+ EQY-4-283-DP+			
Die Ordering and packaging information	<sup>†</sup> <i>Available upon request contact sales representative</i> Refer to AN-60-067				
Environmental Ratings	ENV80				

\*Known Good Die (KGD) means that the die are taken from PCM good wafer and then visually inspected per Mini-Circuits' criteria. Though this is not definitive, it does provide a higher degree of confidence that die are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

#### ESD Rating\*\*

Human Body Model (HBM): Class 2 (Pass 2000V) in accordance with ANSI/ESD STM 5.1 - 2001

\*\* Tested in industry standard 2 x 2mm, 6-lead MCLP package

#### **Additional Notes**

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
- B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.
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